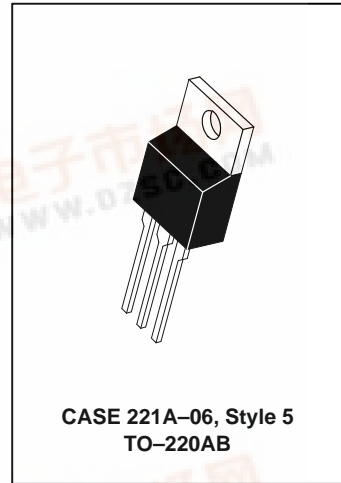
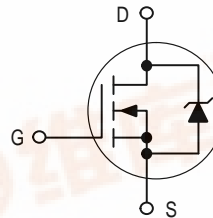


Designer's™ Data Sheet  
**TMOS IV**  
**Power Field Effect Transistor**  
**N-Channel Enhancement-Mode Silicon Gate**

**MTP10N10E**

**TMOS POWER FETs**  
**10 AMPERES**  
**100 VOLTS**  
**RDS(on) = 0.25 OHM**

This advanced "E" series of TMOS power MOSFETs is designed to withstand high energy in the avalanche and commutation modes. These new energy efficient devices also offer drain-to-source diodes with fast recovery times. Designed for low voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating area are critical, and offer additional safety margin against unexpected voltage transients.



- Internal Source-to-Drain Diode Designed to Replace External Zener Transient Suppressor — Absorbs High Energy in the Avalanche Mode — Unclamped Inductive Switching (UIS) Energy Capability Specified at 100°C
- Commutating Safe Operating Area (CSOA) Specified for Use in Half and Full Bridge Circuits
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits

**MAXIMUM RATINGS** (T<sub>C</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	100	Vdc
Drain-Gate Voltage (R <sub>GS</sub> = 1.0 MΩ)	V <sub>DGR</sub>	100	Vdc
Gate-Source Voltage	V <sub>GS</sub>	±20	Vdc
Drain Current — Continuous	I <sub>D</sub>	10	Adc
— Pulsed	I <sub>DM</sub>	25	
Total Power Dissipation Derate above 25°C	P <sub>D</sub>	75 0.6	Watts W/°C
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-65 to 150	°C

**THERMAL CHARACTERISTICS**

Thermal Resistance — Junction to Case	R <sub>θJC</sub>	1.67	°C/W
— Junction to Ambient	R <sub>θJA</sub>	62.5	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	T <sub>L</sub>	275	°C

**Designer's Data for "Worst Case" Conditions** — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

Designer's is a trademark of Motorola, Inc. TMOS is a registered trademark of Motorola, Inc.



# MTP10N10E

## ELECTRICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
<b>OFF CHARACTERISTICS</b>				
Drain–Source Breakdown Voltage (V <sub>GS</sub> = 0, I <sub>D</sub> = 0.25 mA)	V <sub>(BR)DSS</sub>	100	—	Vdc
Zero Gate Voltage Drain Current (V <sub>DS</sub> = Rated V <sub>DSS</sub> , V <sub>GS</sub> = 0) (V <sub>DS</sub> = 0.8 Rated V <sub>DSS</sub> , V <sub>GS</sub> = 0, T <sub>J</sub> = 125°C)	I <sub>DSS</sub>	—	10 80	μA
Gate–Body Leakage Current, Forward (V <sub>GSF</sub> = 20 Vdc, V <sub>DS</sub> = 0)	I <sub>GSSF</sub>	—	100	nAdc
Gate–Body Leakage Current, Reverse (V <sub>GSR</sub> = 20 Vdc, V <sub>DS</sub> = 0)	I <sub>GSSR</sub>	—	100	nAdc

## ON CHARACTERISTICS\*

Gate Threshold Voltage (V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 1.0 mA) T <sub>J</sub> = 100°C	V <sub>GS(th)</sub>	2.0 1.5	4.5 4.0	Vdc
Static Drain–Source On–Resistance (V <sub>GS</sub> = 10 Vdc, I <sub>D</sub> = 5.0 Adc)	R <sub>DS(on)</sub>	—	0.25	Ohm
Drain–Source On–Voltage (V <sub>GS</sub> = 10 V) (I <sub>D</sub> = 10 Adc) (I <sub>D</sub> = 5.0 Adc, T <sub>J</sub> = 100°C)	V <sub>DS(on)</sub>	—	2.7 2.4	Vdc
Forward Transconductance (V <sub>DS</sub> = 15 V, I <sub>D</sub> = 5.0 A)	g <sub>FS</sub>	4.0	—	mhos

## DRAIN–TO–SOURCE AVALANCHE CHARACTERISTICS

Unclamped Drain–to–Source Avalanche Energy See Figures 14 and 15 (I <sub>D</sub> = 25 A, V <sub>DD</sub> = 25 V, T <sub>C</sub> = 25°C, Single Pulse, Non–repetitive) (I <sub>D</sub> = 10 A, V <sub>DD</sub> = 25 V, T <sub>C</sub> = 25°C, P.W. ≤ 200 μs, Duty Cycle ≤ 1%) (I <sub>D</sub> = 4.0 A, V <sub>DD</sub> = 25 V, T <sub>C</sub> = 100°C, P.W. ≤ 200 μs, Duty Cycle ≤ 1%)	W <sub>DSR</sub>	—	60 100 40	mJ
--	------------------	---	-----------------	----

## DYNAMIC CHARACTERISTICS

Input Capacitance	(V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0, f = 1.0 MHz) See Figure 16	C <sub>iss</sub>	—	600	pF
Output Capacitance		C <sub>oss</sub>	—	400	
Reverse Transfer Capacitance		C <sub>rss</sub>	—	100	

## SWITCHING CHARACTERISTICS\* (T<sub>J</sub> = 100°C)

Turn–On Delay Time	(V <sub>DD</sub> = 25 V, I <sub>D</sub> = 5.0 A, R <sub>G</sub> = 50 Ω) See Figure 9	t <sub>d(on)</sub>	—	50	ns
Rise Time		t <sub>r</sub>	—	80	
Turn–Off Delay Time		t <sub>d(off)</sub>	—	100	
Fall Time		t <sub>f</sub>	—	80	
Total Gate Charge	(V <sub>DS</sub> = 0.8 Rated V <sub>DSS</sub> , I <sub>D</sub> = Rated I <sub>D</sub> , V <sub>GS</sub> = 10 V) See Figures 17 and 18	Q <sub>g</sub>	15 (Typ)	30	nC
Gate–Source Charge		Q <sub>gs</sub>	8.0 (Typ)	—	
Gate–Drain Charge		Q <sub>gd</sub>	7.0 (Typ)	—	

## SOURCE–DRAIN DIODE CHARACTERISTICS\*

Forward On–Voltage	(I <sub>S</sub> = Rated I <sub>D</sub> V <sub>GS</sub> = 0)	V <sub>SD</sub>	1.4 (Typ)	1.7	Vdc
Forward Turn–On Time		t <sub>on</sub>	Limited by stray inductance		
Reverse Recovery Time		t <sub>rr</sub>	70 (Typ)	—	ns

## INTERNAL PACKAGE INDUCTANCE

Internal Drain Inductance (Measured from the contact screw on tab to center of die) (Measured from the drain lead 0.25" from package to center of die)	L <sub>d</sub>	3.5 (Typ) 4.5 (Typ)	—	nH
Internal Source Inductance (Measured from the source lead 0.25" from package to source bond pad)	L <sub>s</sub>	7.5 (Typ)	—	

\* Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%.

TYPICAL ELECTRICAL CHARACTERISTICS

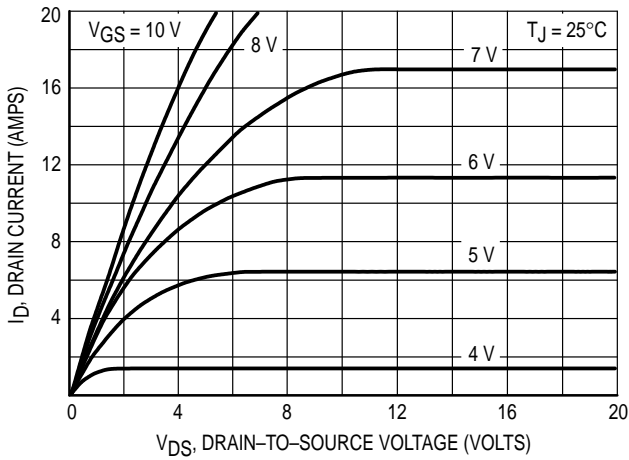


Figure 1. On-Region Characteristics

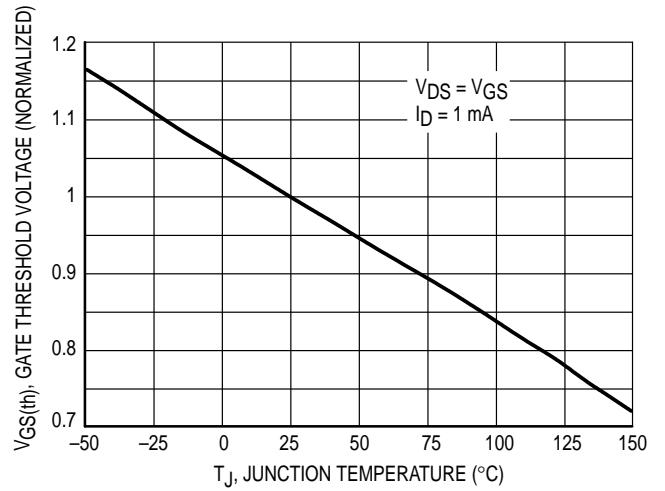


Figure 2. Gate-Threshold Voltage Variation With Temperature

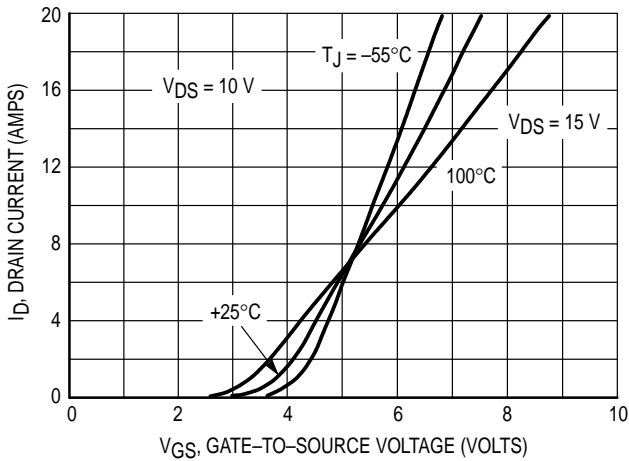


Figure 3. Transfer Characteristics

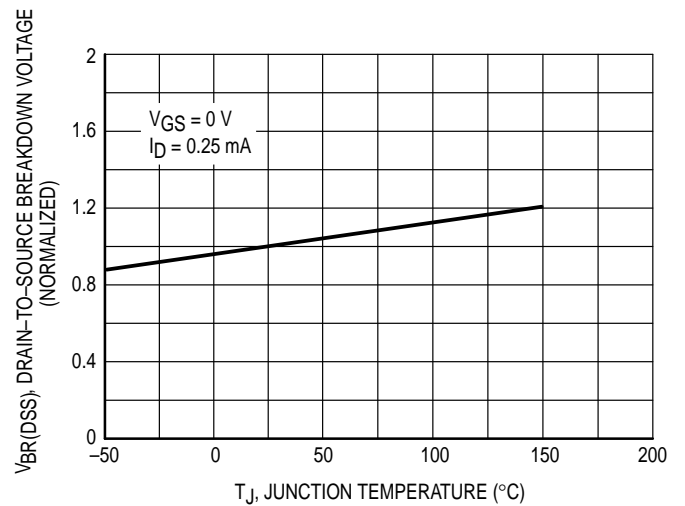


Figure 4. Breakdown Voltage Variation With Temperature

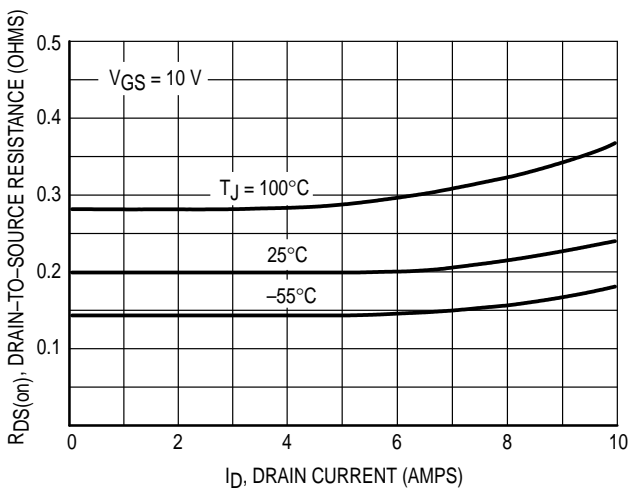


Figure 5. On-Resistance versus Drain Current

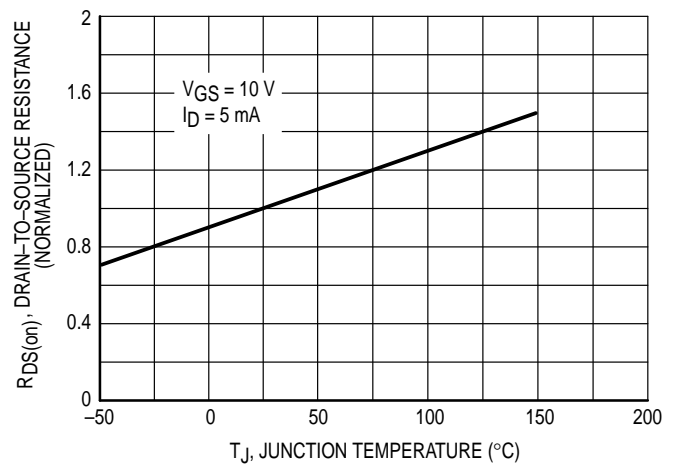
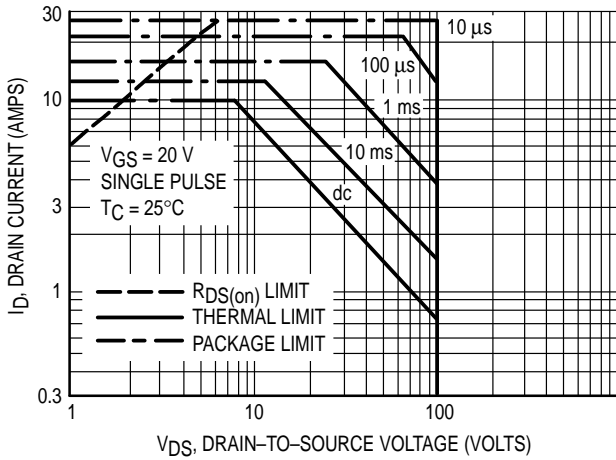


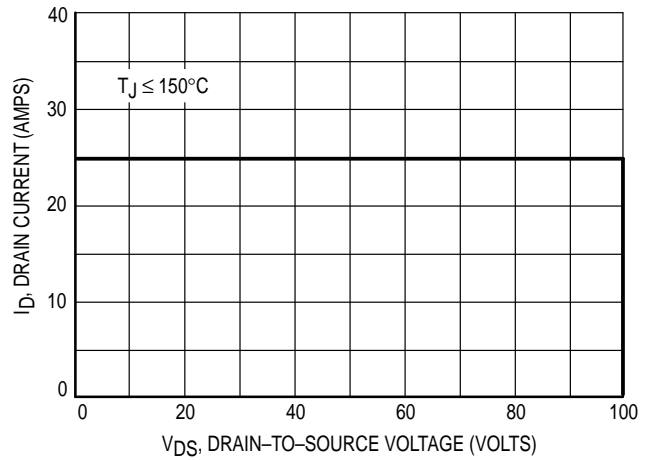
Figure 6. On-Resistance Variation With Temperature

# MTP10N10E

## SAFE OPERATING AREA INFORMATION



**Figure 7. Maximum Rated Forward Biased Safe Operating Area**



**Figure 8. Maximum Rated Switching Safe Operating Area**

### FORWARD BIASED SAFE OPERATING AREA

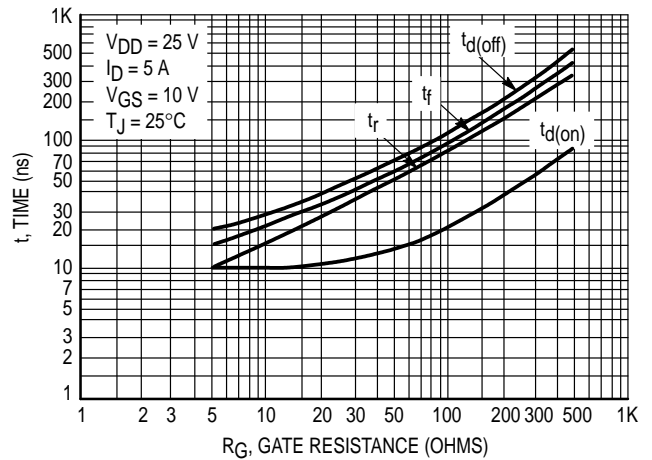
The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance—General Data and Its Use" provides detailed instructions.

### SWITCHING SAFE OPERATING AREA

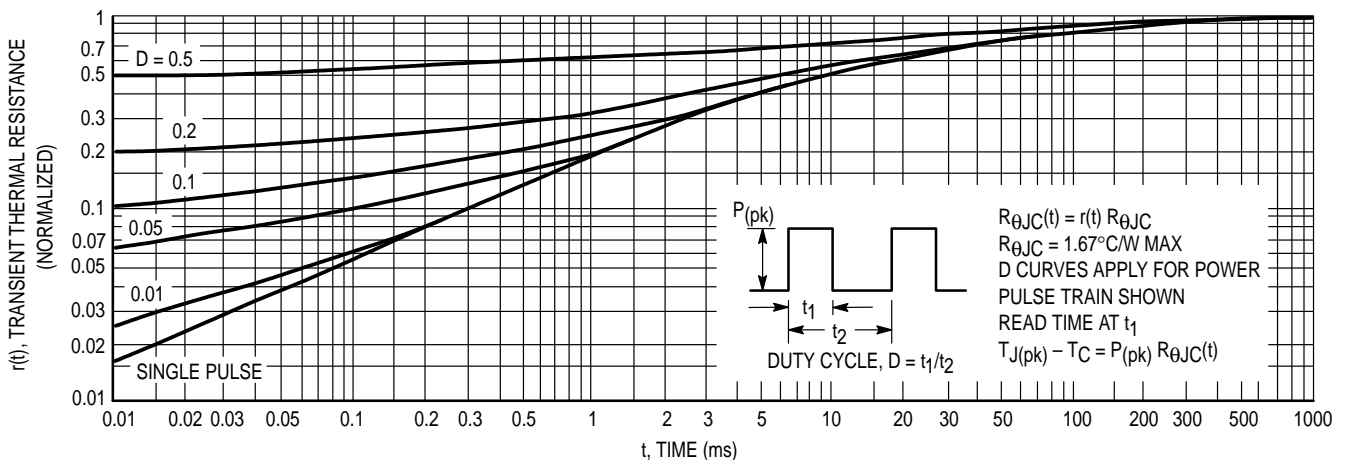
The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current,  $I_{DM}$  and the breakdown voltage,  $V_{(BR)DSS}$ . The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$\frac{T_{J(max)} - T_C}{R_{\theta JC}}$$



**Figure 9. Resistive Switching Time versus Gate Resistance**



**Figure 10. Thermal Response**

COMMUTATING SAFE OPERATING AREA (CSOA)

The Commutating Safe Operating Area (CSOA) of Figure 12 defines the limits of safe operation for commutated source-drain current versus re-applied drain voltage when the source-drain diode has undergone forward bias. The curve shows the limitations of  $I_{FM}$  and peak  $V_{DS}$  for a given rate of change of source current. It is applicable when waveforms similar to those of Figure 11 are present. Full or half-bridge PWM DC motor controllers are common applications requiring CSOA data.

Device stresses increase with increasing rate of change of source current so  $di_s/dt$  is specified with a maximum value. Higher values of  $di_s/dt$  require an appropriate derating of  $I_{FM}$ , peak  $V_{DS}$  or both. Ultimately  $di_s/dt$  is limited primarily by device, package, and circuit impedances. Maximum device stress occurs during  $t_{rr}$  as the diode goes from conduction to reverse blocking.

$V_{DS(pk)}$  is the peak drain-to-source voltage that the device must sustain during commutation;  $I_{FM}$  is the maximum forward source-drain diode current just prior to the onset of commutation.

$V_R$  is specified at 80% of  $V_{(BR)DSS}$  to ensure that the CSOA stress is maximized as  $I_S$  decays from  $I_{RM}$  to zero.

$R_{GS}$  should be minimized during commutation.  $T_J$  has only a second order effect on CSOA.

Stray inductances in Motorola's test circuit are assumed to be practical minimums.  $dV_{DS}/dt$  in excess of 10 V/ns was attained with  $di_s/dt$  of 400 A/ $\mu$ s.

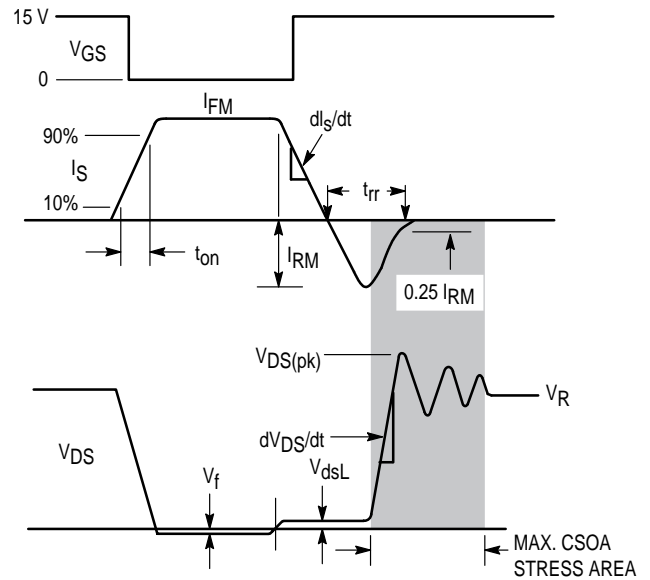


Figure 11. Commutating Waveforms

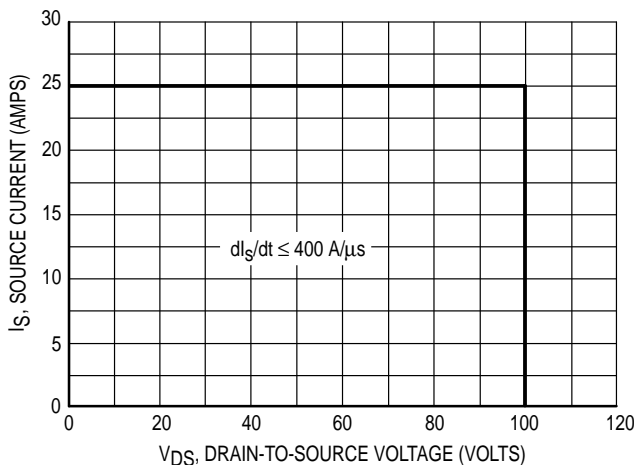


Figure 12. Commutating Safe Operating Area (CSOA)

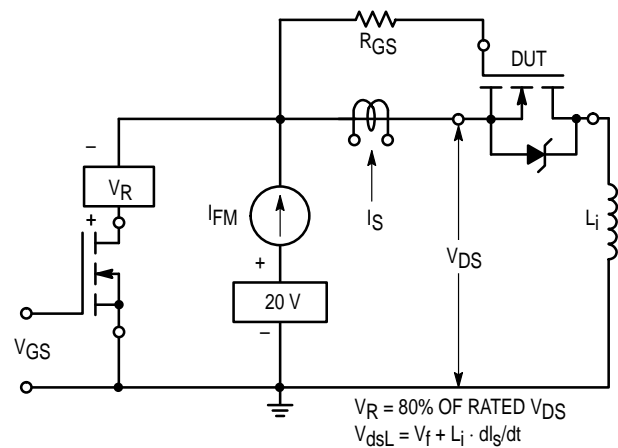


Figure 13. Commutating Safe Operating Area Test Circuit

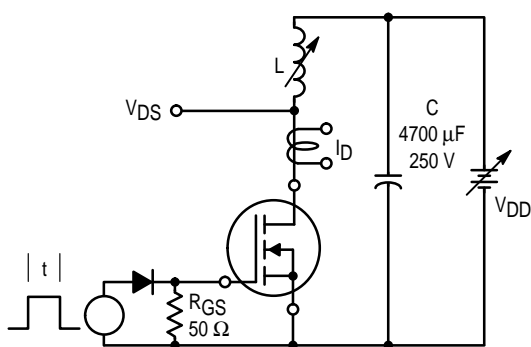


Figure 14. Unclamped Inductive Switching Test Circuit

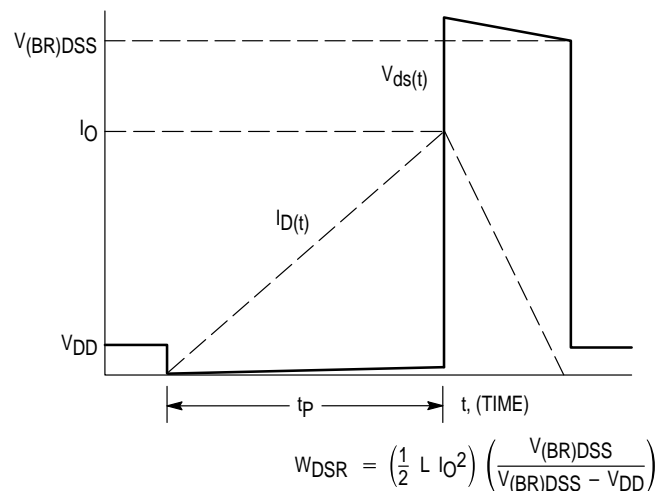
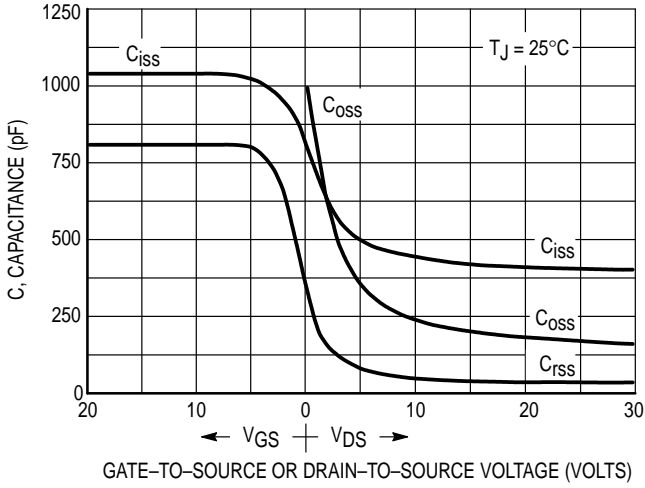
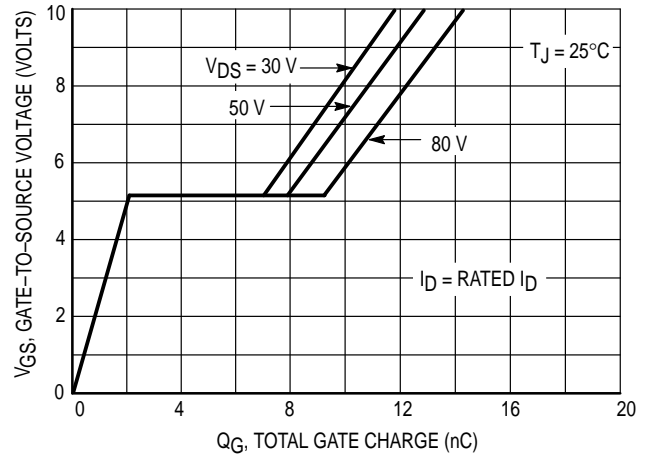


Figure 15. Unclamped Inductive Switching Waveforms

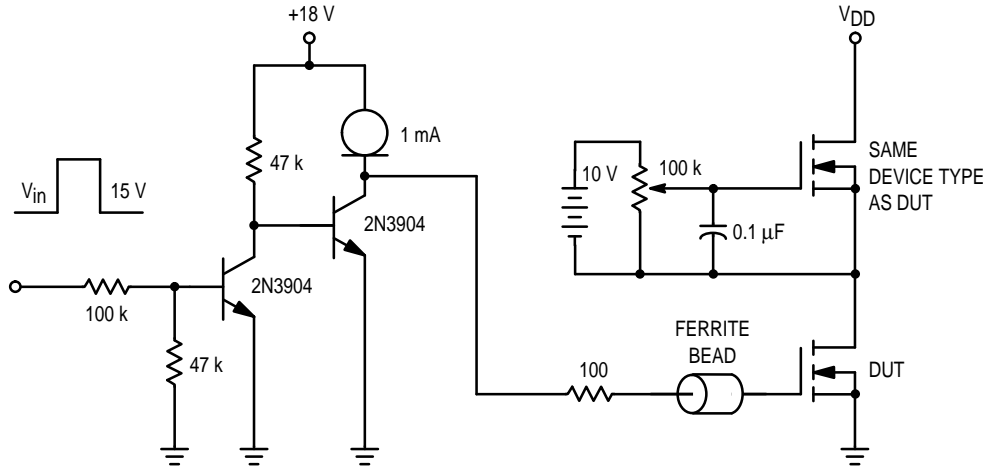
# MTP10N10E



**Figure 16. Capacitance Variation**



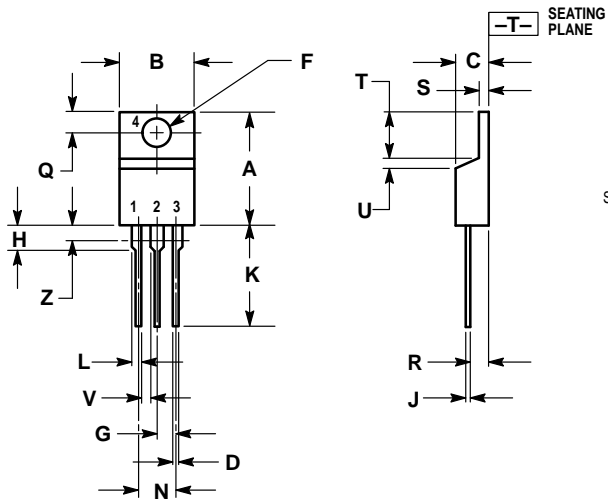
**Figure 17. Gate Charge versus Gate-To-Source Voltage**



$V_{in} = 15\text{V}_{pk}$ ; PULSE WIDTH  $\leq 100\ \mu\text{s}$ , DUTY CYCLE  $\leq 10\%$

**Figure 18. Gate Charge Test Circuit**

PACKAGE DIMENSIONS




STYLE 5:  
 PIN 1. GATE  
 2. DRAIN  
 3. SOURCE  
 4. DRAIN

- NOTES:  
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.  
 2. CONTROLLING DIMENSION: INCH.  
 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.570	0.620	14.48	15.75
B	0.380	0.405	9.66	10.28
C	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
H	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045	—	1.15	—
Z	—	0.080	—	2.04

CASE 221A-06  
 ISSUE Y

## MTP10N10E

Motorola reserves the right to make changes without further notice to any products herein. Motorola makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Motorola assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters can and do vary in different applications. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. Motorola does not convey any license under its patent rights nor the rights of others. Motorola products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Motorola product could create a situation where personal injury or death may occur. Should Buyer purchase or use Motorola products for any such unintended or unauthorized application, Buyer shall indemnify and hold Motorola and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Motorola was negligent regarding the design or manufacture of the part. Motorola and  are registered trademarks of Motorola, Inc. Motorola, Inc. is an Equal Opportunity/Affirmative Action Employer.

### How to reach us:

**USA / EUROPE:** Motorola Literature Distribution;  
P.O. Box 20912; Phoenix, Arizona 85036. 1-800-441-2447

**MFAX:** RMFAX0@email.sps.mot.com – TOUCHTONE (602) 244-6609  
**INTERNET:** <http://Design-NET.com>

**JAPAN:** Nippon Motorola Ltd.; Tatsumi-SPD-JLDC, Toshikatsu Otsuki,  
6F Seibu-Butsuryu-Center, 3-14-2 Tatsumi Koto-Ku, Tokyo 135, Japan. 03-3521-8315

**HONG KONG:** Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park,  
51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852-26629298

